

Notice of References Cited	Application/Control No. 09/839,594	Applicant(s)/Patent Under Reexamination PARK ET AL.	
	Examiner Khiem D Nguyen	Art Unit 2823	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,232,777	05-2001	Sato et al.	
	B	US-6,063,303	05-2000	Hitoshi Ohtaki	
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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